10/733, 431

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Cecile BERNE et al.

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	December 10, 2003						2812		
			U.S. F	PATENT DOCUM	IENTS				
*EXAMINER INITIAL		DOCUMENT NUMBER	NT NUMBER DATE		NAME		SUBCLASS	FILING DA APPROPR	ATE IP SATE
EP	AA	5,877,070	3/1999	Goesele et al.		438	458		
Ef	AB	6,303,468	10/2001	Aspar et al.		438	455		
	AC								
	AD								
	AE.								
	AF								
			FOREI	GN PATENT DOC	IMENTS				
		DOCUMENT NUMBER	DATE	α	UNTRY	CLASS	SUBCLASS	YES	NO
Ef	AG	FR 2767416 w/ English Abstract	2/1999	France	8,303,4	68	A	X	ì. C
•	AH				correr	p. n. d. r. J.		ļ	
	ΑJ								_
	AJ								
		OTHER REFI	ERENCES (Inc	cluding Author, Ti	le, Date, Pertinent Pa	iges, Etc.)			
A	AK	B. Aspar et al: XP001050558 "The Generic Nature Of The Smart-Cut Process For Thin Film Transfer", Journal Of Electronic Materials, Vol. 30, No. 7, 22, pp. 834-840, (2001)							
SI	AL	B. Aspar et al: XP000884996, "Smart-Cut Technology: An Industrial Application Of Ion Implementation Induced Cavities", Materials Research Society Symposium Proceedings, Materials Research Society, Vol. 510, No. 13, pp 381-393 (19998)							
	AM								
		EXAMINER	^	DATE	CONSIDERED				

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